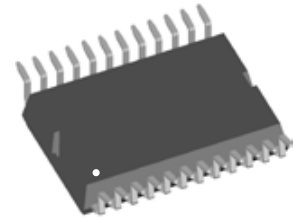
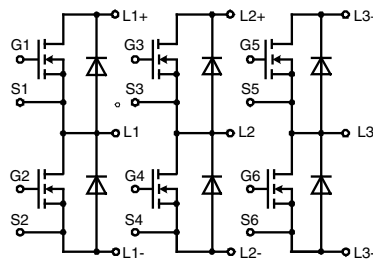


## Three phase full Bridge with Trench MOSFETs in DCB isolated high current package

$V_{DSS} = 75 \text{ V}$   
 $I_{D25} = 110 \text{ A}$   
 $R_{DSon \text{ typ.}} = 4.0 \text{ m}\Omega$



MOSFETs			
Symbol	Conditions	Maximum Ratings	
$V_{DSS}$	$T_{VJ} = 25^\circ\text{C to } 150^\circ\text{C}$	75	V
$V_{GS}$		$\pm 20$	V
$I_{D25}$	$T_C = 25^\circ\text{C}$	110	A
$I_{D90}$	$T_C = 90^\circ\text{C}$	85	A
$I_{F25}$	$T_C = 25^\circ\text{C}$ (diode)	110	A
$I_{F90}$	$T_C = 90^\circ\text{C}$ (diode)	80	A

### Applications

- AC drives
  - in automobiles
    - electric power steering
    - starter generator
  - in industrial vehicles
    - propulsion drives
    - fork lift drives
- in battery supplied equipment

### Features

- MOSFETs in trench technology:
  - low  $R_{DSon}$
  - optimized intrinsic reverse diode
- package:
  - high level of integration
  - high current capability
  - aux. terminals for MOSFET control
  - terminals for soldering or welding connections
  - isolated DCB ceramic base plate with optimized heat transfer
- Space and weight savings

Symbol	Conditions	Characteristic Values				
		$(T_{VJ} = 25^\circ\text{C}, \text{ unless otherwise specified})$				
		min.	typ.	max.		
$R_{DSon}^{1)}$	on chip level at $V_{GS} = 10 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$		4.0	4.9	$\text{m}\Omega$
		$T_{VJ} = 125^\circ\text{C}$		7.2	8.4	$\text{m}\Omega$
$V_{GS(th)}$	$V_{DS} = 20 \text{ V}; I_D = 1 \text{ mA}$	2.0		4.0	V	
$I_{DSS}$	$V_{DS} = V_{DSS}; V_{GS} = 0 \text{ V}$			1	$\mu\text{A}$	
			50		$\mu\text{A}$	
$I_{GSS}$	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$			0.2	$\mu\text{A}$	
$Q_g$	$V_{GS} = 10 \text{ V}; V_{DS} = 36 \text{ V}; I_D = 25 \text{ A}$		115		nC	
$Q_{gs}$			30		nC	
$Q_{gd}$			30		nC	
$t_{d(on)}$	inductive load $V_{GS} = 10 \text{ V}; V_{DS} = 30 \text{ V}$ $I_D = 80 \text{ A}; R_G = 39 \Omega;$ $T_J = 125^\circ\text{C}$		130		ns	
$t_r$			100		ns	
$t_{d(off)}$			500		ns	
$t_f$			100		ns	
$E_{on}$			0.20		mJ	
$E_{off}$			0.50		mJ	
$E_{recoff}$		0.01		mJ		
$R_{thJC}$	with heat transfer paste (IXYS test setup)			1.0	K/W	
$R_{thJH}$			1.3	1.6	K/W	

<sup>1)</sup>  $V_{DS} = I_D \cdot (R_{DS(on)} + 2R_{Pin \text{ to Chip}})$

**Source-Drain Diode**

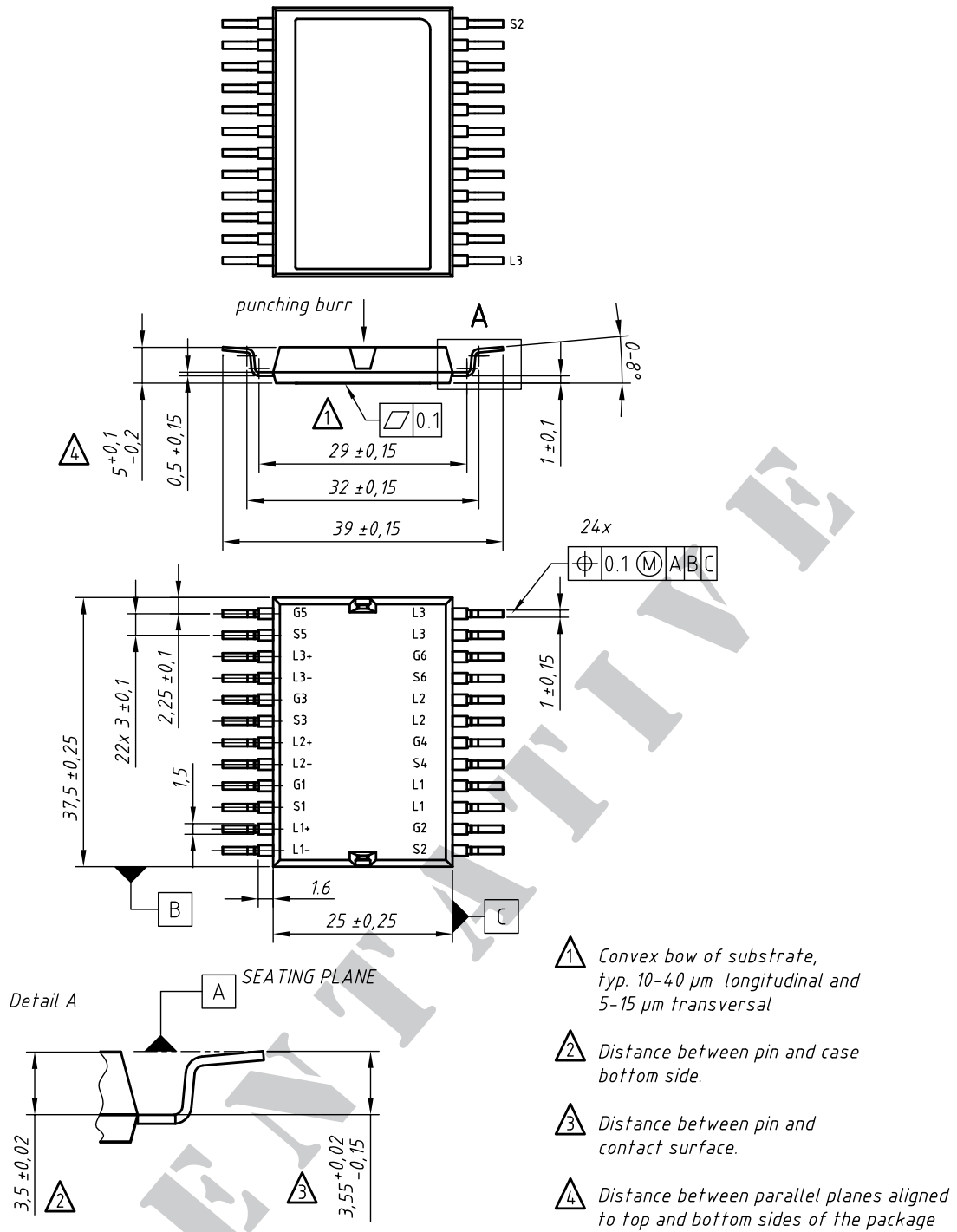
Symbol	Conditions	Characteristic Values			
		min.	typ.	max.	
$V_{SD}$	(diode) $I_F = 80 \text{ A}$ ; $V_{GS} = 0 \text{ V}$	0.9	1.2		V
$t_{rr}$	$I_F = 80 \text{ A}$ ; $-di_F/dt = 800 \text{ A}/\mu\text{s}$ ; $V_R = 30 \text{ V}$		55		ns
$Q_{RM}$			0.9		$\mu\text{C}$
$I_{RM}$			30		A

(T<sub>J</sub> = 25°C, unless otherwise specified)**Component**

Symbol	Conditions	Maximum Ratings	
$I_{RMS}$	per pin in main current paths (P+, N-, L1, L2, L3) may be additionally limited by external connections 2 pins for output L1, L2, L3	75	A
$T_J$		-55...+175	°C
$T_{stg}$		-55...+125	°C
$V_{ISOL}$	$I_{ISOL} \leq 1 \text{ mA}$ , 50/60 Hz, f = 1 minute	1000	V~
$F_C$	mounting force with clip	50 - 250	N

Symbol	Conditions	Characteristic Values			
		min.	typ.	max.	
$R_{pin \text{ to chip}}^{1)}$			tbd		mΩ
$C_P$	coupling capacity between shorted pins and back side metallization		160		pF
<b>Weight</b>			25		g

<sup>1)</sup>  $V_{DS} = I_D \cdot (R_{DS(on)} + 2R_{Pin \text{ to Chip}})$

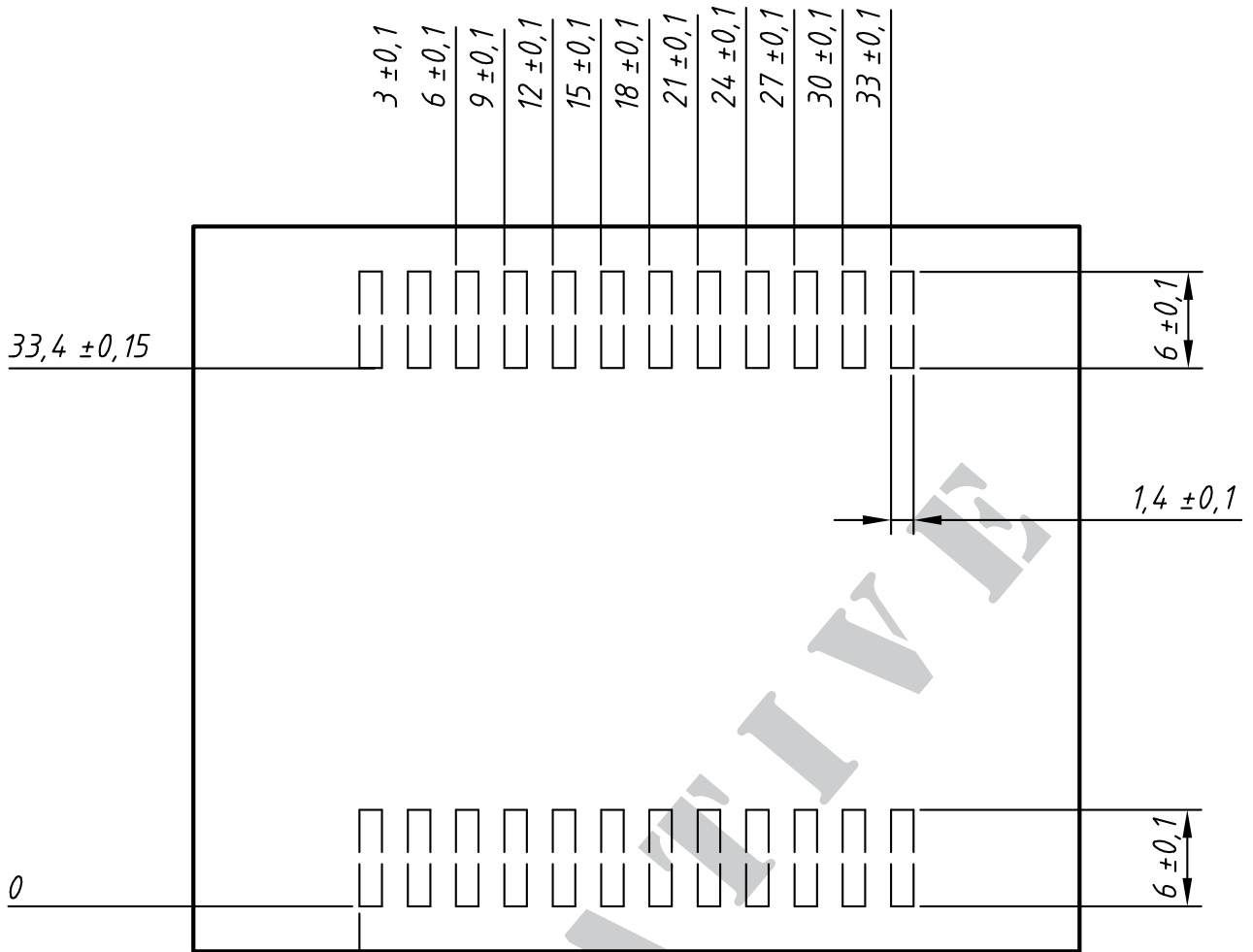


contact pin:  
 - galv. tin plating, per pin side: Sn  $10...25 \mu\text{m}$ , undercoating Ni  $0,2...1 \mu\text{m}$   
 - stamping edges may be free of tin  
 - punching burr:  $\leq 0,05\text{mm}$

Leads	Ordering	Part Name & Packing Unit Marking	Part Marking	Delivering Mode	Base Qty.	Ordering Code
SMD	Standard	GMM 3x120-0075X2 - SMD	GMM 3x120-0075X2	Blister	28	507 508

IXYS reserves the right to change limits, test conditions and dimensions.

20110307



Remarks:

- 1) pin layout / dimensions are conditionally
- 2) soldering paste thickness: 200µm